

<b>Notice of References Cited</b>	Application/Control No. 09/931,082	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Christopher D RoDee	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0106571	08-2002	Katagiri et al.	430/108.23
	B	US-2002/0061456	05-2002	Takezawa et al.	430/108.2
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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